

<b>Search Notes</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/001,761	AMON ET AL.
	Examiner	Art Unit
	Sean Reilly	2153

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor and Assignee double patenting search	10/27/2005	SR
See attached EAST text search	10/27/2005	SR
Searched NPL: ACM, IEEE, Google.com, Google groups, citeseer.com, WSJ, Financial Times	10/27/2005	SR
STIC 705 mandatory database search by Geoffrey St. Leger	10/27/2005	SR
Consulted w/ Examiner Dinh	10/26/2005	SR
Consulted w/ 705/14 Examiners Janes Myhre and Yehdega Retta	10/26/2005	SR
Consulted w/ SPREs Brian Johnson and Vincent Trans	10/26/2005	SR